

NATIONAL RADIO ASTRONOMY OBSERVATORY
GREEN BANK, WEST VIRGINIA

ELECTRONICS DIVISION INTERNAL REPORT No. 216

DESIGNS OF 300-1000 MHz UPPER SIDEBAND CONVERTERS

ALBERT WU

JULY 1981

NUMBER OF COPIES: 150

NATIONAL RADIO ASTRONOMY OBSERVATORY

DESIGNS OF 300-1000 MHz UPPER SIDEBAND CONVERTERS

Albert Wu

Introduction

The purpose of this report is to describe the design and performance of the upconverters used in the 300-1000 MHz receiver box. The noise contribution of the upconverter to the system, theoretically, is negligible, which we have found to be quite accurate. There were three sets of such upconverters designed and working in our traveling feed receiver. One set of upconverters operate from 300 to 400 MHz with approximately 10 dB of gain. A second set of upconverters work from 500-700 MHz with approximately 7 dB of gain. A third set of upconverters operate from 700-1000 MHz with approximately 5.5 dB gain.

Manley and Rowe derived a set of general relationships of power and frequencies in an ideal (non-resistive) non-linear reactance which basically shows that, given two high-frequency generators feeding power to a non-linear reactive element will give rise to several other frequencies from the non-linear reactance. The impedance of the non-linear reactive element will appear negative; therefore, if we send a signal into it we will find gain. The gain of the upper sideband upconverter can be calculated by the voltage and current relationships given in the Manley and Rowe matrix, but the end result will be described by an equation that contains the characteristics of the reactive element, in our case the varactor diode.

The varactor diode is a device that has a capacitive reactance that changes with the voltages impressed upon it. Although a varactor is not a purely non-linear capacitor, it does have other characteristics which will be shown in the equivalent circuit, Figure 1B.

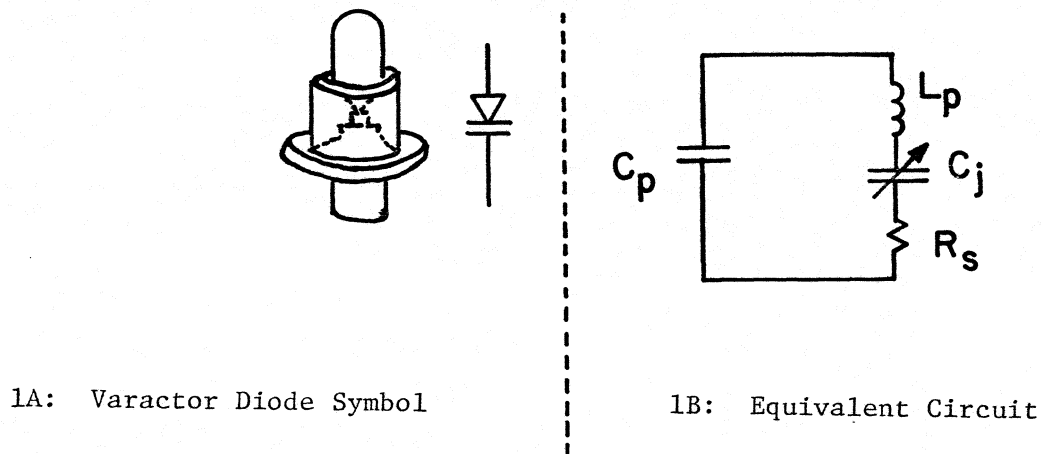


FIGURE 1

Table 1

| Upconverter Frequency | | Gain max (dB) | Noise Temperature [1] ($^{\circ}$ K) | Noise Temperature [2] ($^{\circ}$ K) | R_g Maximum Gain (ohms) |
|-----------------------|---------|---------------|---------------------------------------|---------------------------------------|---------------------------|
| .35 | D_1^* | 10.87 | 9.84 | .66 | 26.29 |
| | D_2^* | 10.69 | 16.17 | 1.08 | 31.57 |
| .60 | D_1^* | 8.53 | 13.72 | .92 | 19.87 |
| | D_2^* | 8.30 | 22.62 | 1.51 | 23.88 |
| .85 | D_1^* | 6.91 | | 1.14 | 16.79 |
| | D_2^* | 6.63 | 28.37 | 1.89 | 20.19 |

$$*D_1 = f_{C6} = 2.50$$

$$*D_1 R_s = 0.8246 \Omega$$

$$D_2 = f_{C6} = 1.50$$

$$D_2 R_s = 1.6224 \Omega$$

[1] Varactor at 300° K.

[2] Varactor at 20° K.

As long as the varactor diode is in reverse bias, the above equivalent circuit can be considered accurate enough for analysis.

An upconverter will have three major frequencies involved. For instance, the signal frequency range in our case is 300-400 MHz. The pump frequency is at 4.2 GHz. Our output frequency is the sum of the signal and the pump frequency; in this case it would be 4.5-4.6 GHz.

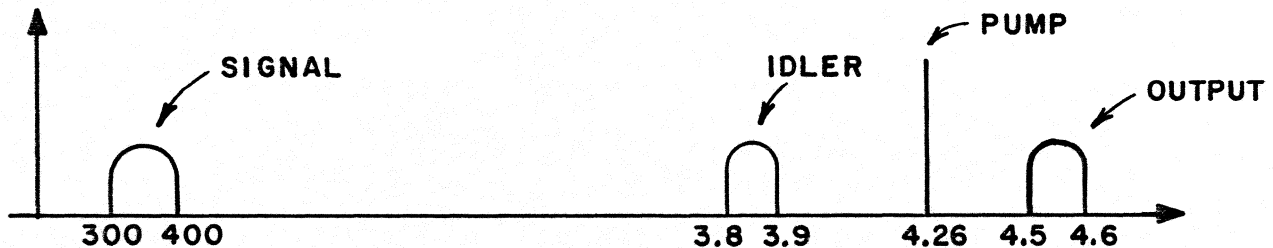


FIG. 2

In an upper sideband converter we will try to suppress the idler frequencies which is the difference between the pump and the signal frequencies, called the idler. This idler is what is enhanced in a parametric amplifier that would give us a large amount of gain. Whereas the upper sideband upconverter will have gains in direct ratio of the signal and pump frequencies modified by the varactor characteristics, namely, resistive losses. It turns out that the gain of the upconverter depends somewhat on the Q or the losses in the varactor diode.

The lower the R_s in the varactor the higher the Q of the varactor. There is, however, a trade off here because if we made Q of the varactor very high we will approach the theoretical gain of $(F_p + F_s)/F_s$, but the bandwidth would suffer because the Q is so high we will have a very narrow band of very high gain at the center of the signal frequency and the fall-off is too fast. So, to compromise, we select a varactor with a Q of about 100. We find that we can have about 25% to 35% bandwidth at the signal frequency.

Design Considerations

Varactor specifications:

In order to tune the signal circuit to resonance, we must have an inductor in series with the varactor diode. For 300 MHz, we will have a relatively large inductor, so I bought the highest capacitance diode I could find, which is about 1.0 pF. An 0.2 μ H inductor was necessary to resonate the signal circuit. With the capacitance of the varactor determined, we use an analysis routine on the 9825A calculator to find the gain and noise of the upconverter. The equations for the 9825A program were entirely from the book by Blackwell and Kotzbue entitled Semiconductor-Diode Parametric Amplifiers.

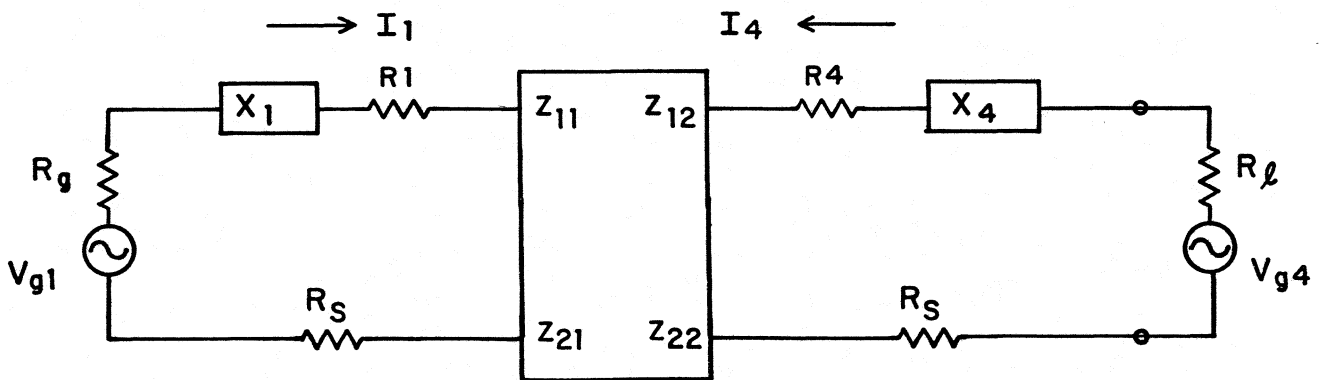


FIG. 3

$$\text{Power output} = |I_4|^2 R_L$$

$$\text{Power input} = |V_{g1}|^2 / 4 R_g$$

$$\begin{aligned} Z_{T1} &= \text{Total external circuit impedance at } f_1 \\ &= X_1 + R_g + R_s + R_1 \end{aligned}$$

$$\begin{aligned} Z_{T4} &= \text{Total external circuit impedance at } f_4 \\ &= X_4 + R + R_s + R_4 \end{aligned}$$

$$\begin{aligned} \text{Transducer gain } g_t &= \frac{4 R_g R_\ell |I_4|^2}{|V_{g_1}|^2} \\ &= \frac{4 R_g R_\ell |Z_{21}|^2}{\left| (Z_{11} + Z_{T_1}) (Z_{22} + Z_{T_4}) - Z_{12} Z_{21} \right|^2} \end{aligned}$$

At mid-band, assuming

$$-X_1 = Z_{11} \quad , \quad X_4 = Z_{22}$$

This means the matched input and output

$$g_t = \frac{4 R_g R_\ell \delta^2}{(\omega_1 C)^2} \cdot \frac{1}{\left[R_{T_1} R_{T_4} + \frac{\delta^2}{\omega_1 \omega_4 C^2} \right]^2}$$

To simplify, assume

$$R_{T_1} = R_g + R_s \quad , \quad R_{T_4} = R_\ell + R_s$$

and

$$g_t = \frac{4 R_g R_\ell}{\left[(R_g + R_s) (R_\ell + R_s) \frac{\omega_1 C}{\delta} + \frac{\delta}{\omega_4 C} \right]^2}$$

For maximum gain

$$R_g = R_\ell$$

and

$$R_g = R_s \sqrt{1 + \frac{\delta}{\omega_1 \omega_4 C^2 R_s^2}}$$

since $1/\omega C R_s$ is defined as the effective Q of the varactor

$$R_g = R_s \sqrt{1 + \frac{\omega_1}{\omega_4} (\delta Q)^2}$$

With R_g as given above, we find

$$g_t = \frac{\omega_4}{\omega_1} \cdot \frac{\omega_1 \omega_4 (\delta Q)^2}{1 + \sqrt{1 + \omega_1/\omega_4} (\gamma Q)^2}$$

Let $\omega_1/\omega_4 (\delta Q)^2 = \chi$

$$g_t = \frac{\omega_4}{\omega_1} \cdot \frac{\chi}{[1 + \sqrt{1 + \chi}]^2}$$

(This is maximum gain at center of band.)

The impedance of the varactor is given by

$$\begin{aligned} Z_{in} &= Z_{11} - \frac{Z_{12} Z_{21}}{Z_{22} + Z_{T_4}} \\ &= \frac{1}{j \omega_1 C} + \frac{\delta^2}{\omega_1 \omega_4 C^2 Z_{T_4} \frac{1}{j \omega_4 C}} \end{aligned}$$

At resonance, all reactive components disappear and we get

$$Z_{in} = \frac{\delta^2}{\omega_1 \omega_4 C^2 R_{T_4}}$$

and by symmetry

$$Z_{out} = \frac{\delta^2}{\omega_1 \omega_4 C^2 R_{T_1}}$$

Varactor Specifications (continued):

The cut-off frequency of a varactor diode is defined as

$$f_{C(v)} = \frac{1}{2\pi R_s C_j(v)}$$

$$Q = \frac{1}{2\pi f C_j R_s}$$

$$\delta = \frac{C_{j(\max)} - C_{j(\min)}}{2(C_{j(\max)} + C_{j(\min)})}$$

$C_{j(\max)}$ and $C_{j(\min)}$ are usually defined, by the manufacturer, to be the capacitance at zero bias ($C_{j \max}$) and 6 V reverse bias for ($C_{j \min}$); for a GaAs varactor is usually 0.25.

With our decision made on an output frequency of 4.55 GHz and the first set of upconverters covering 300 MHz, we calculate the Q of the varactor at somewhere around 350 MHz. We find that we will have a Q of over 300. Faced with such high Q's, we must be limited to the bandwidths we can get at the input frequencies

$$BW = \frac{\omega_0}{Q} \quad \omega_0 = \text{center frequency}$$

According to this equation, with a single tuned input to our upconverter, the maximum bandwidth would be ~ 7 MHz. We were able to match into the upconverter with one-eighth wave distributed parameter transformers and some lumped constant shunt stubs to coax about 25 % bandwidth from the upconverter. In fact, at the higher frequencies the input Q of the varactors are lower. We were able to get up to 35% bandwidths from the upconverters.

Table 2

Analysis of Upconverters at Cryogenic Temperatures

| Up Converter | Up Converter | Up Converter |
|---------------------|---------------------|---------------------|
| Sig Freq(GHz) | Sig Freq(GHz) | Sig Freq(GHz) |
| .35 | .6 | .85 |
| Pump Freq(GHz) | Pump Freq(GHz) | Pump Freq(GHz) |
| 4.2 | 4.05 | 3.75 |
| Cj0(pf) | Cj0(pf) | Cj0(pf) |
| 1.156 | 1.156 | 1.156 |
| Cj6(pf) | Cj6(pf) | Cj6(pf) |
| .505 | .505 | .505 |
| Fc6(GHz) | Fc6(GHz) | Fc6(GHz) |
| 275 | 275 | 275 |
| Diode temp(K) | Diode temp(K) | Diode temp(K) |
| 20 | 20 | 20 |
| Ambient temp(K) | Ambient temp(K) | Ambient temp(K) |
| 300 | 300 | 300 |
| Diode parameters | Diode parameters | Diode parameters |
| Rs(ohm)= 1.1460 | Rs(ohm)= 1.1460 | Rs(ohm)= 1.1460 |
| Qd= 343.2402 | Qd= 200.2235 | Qd= 141.3342 |
| Fc0(GHz)= 120.1341 | Fc0(GHz)= 120.1341 | Fc0(GHz)= 120.1341 |
| For Max Gain | For Max Gain | For Max Gain |
| Rs(ohm)= 27.2989 | Rs(ohm)= 20.6382 | Rs(ohm)= 17.4443 |
| Rin & Rout= 26.1529 | Rin & Rout= 19.4921 | Rin & Rout= 16.2983 |
| Gain(db)= 10.7746 | Gain(db)= 8.4102 | Gain(db)= 6.7619 |
| F(db)= 0.0132 | F(db)= 0.0184 | F(db)= 0.0230 |
| NT(K)= 0.8795 | NT(K)= 1.2284 | NT(K)= 1.5378 |
| For Min Noise | For Min Noise | For Min Noise |
| Rs(ohms)= 98.3476 | Rs(ohms)= 57.3770 | Rs(ohms)= 40.5095 |
| Rin & Rout= 7.4770 | Rin & Rout= 7.2556 | Rin & Rout= 7.2737 |
| Gain(db)= 5.1894 | Gain(db)= 4.6601 | Gain(db)= 4.1346 |
| F(db)= 0.0068 | F(db)= 0.0118 | F(db)= 0.0168 |
| NT(K)= 0.4559 | NT(K)= 0.7881 | NT(K)= 1.1257 |

Table 3

 Analysis of Upconverters at Room Temperature

| Up Converter | Up Converter | Up Converter |
|---------------------|---------------------|---------------------|
| Sig Freq(Ghz) | Sig Freq(Ghz) | Sig Freq(Ghz) |
| .35 | .6 | .85 |
| Pump Freq(Ghz) | Pump Freq(Ghz) | Pump Freq(Ghz) |
| 4.2 | 4.05 | 3.75 |
| Cj0(pf) | Cj0(pf) | Cj0(pf) |
| 1.156 | 1.156 | 1.156 |
| Cj6(pf) | Cj6(pf) | Cj6(pf) |
| .505 | .505 | .505 |
| Fc6(Ghz) | Fc6(Ghz) | Fc6(Ghz) |
| 275 | 275 | 275 |
| Diode temp(K) | Diode temp(K) | Diode temp(K) |
| 300 | 300 | 300 |
| Ambient temp(K) | Ambient temp(K) | Ambient temp(K) |
| 300 | 300 | 300 |
| Diode parameters | Diode parameters | Diode parameters |
| Rs(ohm)= 1.1460 | Rs(ohm)= 1.1460 | Rs(ohm)= 1.1460 |
| Qd= 343.2402 | Qd= 200.2235 | Qd= 141.3342 |
| Fc0(Ghz)= 120.1341 | Fc0(Ghz)= 120.1341 | Fc0(Ghz)= 120.1341 |
| For Max Gain | For Max Gain | For Max Gain |
| Re(ohm)= 27.2989 | Re(ohm)= 20.6382 | Re(ohm)= 17.4443 |
| Rin & Rout= 26.1529 | Rin & Rout= 19.4921 | Rin & Rout= 16.2983 |
| Gain(db)= 10.7746 | Gain(db)= 8.4102 | Gain(db)= 6.7619 |
| F(db)= 0.1932 | F(db)= 0.2675 | F(db)= 0.3324 |
| NT(K)= 13.1930 | NT(K)= 18.4258 | NT(K)= 23.0676 |
| For Min Noise | For Min Noise | For Min Noise |
| Re(ohms)= 98.3476 | Re(ohms)= 57.3770 | Re(ohms)= 40.5095 |
| Rin & Rout= 7.4770 | Rin & Rout= 7.2556 | Rin & Rout= 7.2737 |
| Gain(db)= 5.1894 | Gain(db)= 4.6601 | Gain(db)= 4.1346 |
| F(db)= 0.1012 | F(db)= 0.1735 | F(db)= 0.2458 |
| NT(K)= 6.8383 | NT(K)= 11.8208 | NT(K)= 16.8861 |

In conclusion, we want a lower Q varactor diode for large bandwidths but high Q diodes for lower noise contribution. The gain variation is minimal in our case, so we disregarded the gain as a factor in our selection of the varactor diodes. As a matter of fact, we chose varactors with relatively low cut-off frequencies and large capacitances. The large capacitance for signal frequency resonance with relatively small inductances while the low cut-off frequencies to get as much bandwidths as possible.

Circuit Design

We plug our varactor parameters into the equations given by Blackwell and Kutzbue, Semiconductor-Diode Parametric Amplifiers, and find that for maximum gain the input impedance for the 300-400 MHz upconverter would be 25Ω . A distributed parameter one-eighth wavelength with a shunt stub reactance compensation would provide up to 100 MHz bandwidth.

The pump frequency for this upconverter would be 4.2 GHz which will set our output at 4.5-4.6 GHz. The varactor diode in our case is not a frequency selective element; therefore, if we send in signal frequencies and a pump frequency we will get the sums and the differences of the pump and the signal frequencies. Since in an upconverter the sum frequencies are what we want and not the difference frequencies, we must suppress the propagation of the difference frequencies with very sharp filters. A side effect of the propagation of the difference frequencies would be instabilities in the upconverters; that is another reason why we must have very sharp pump filters as well as the output filters to select the wanted outputs from the undesired outputs and their side effects. So the upconverter would have three connections. The signal input port, the pump port and the output port. All three ports are connected to a common point on the varactor diode.

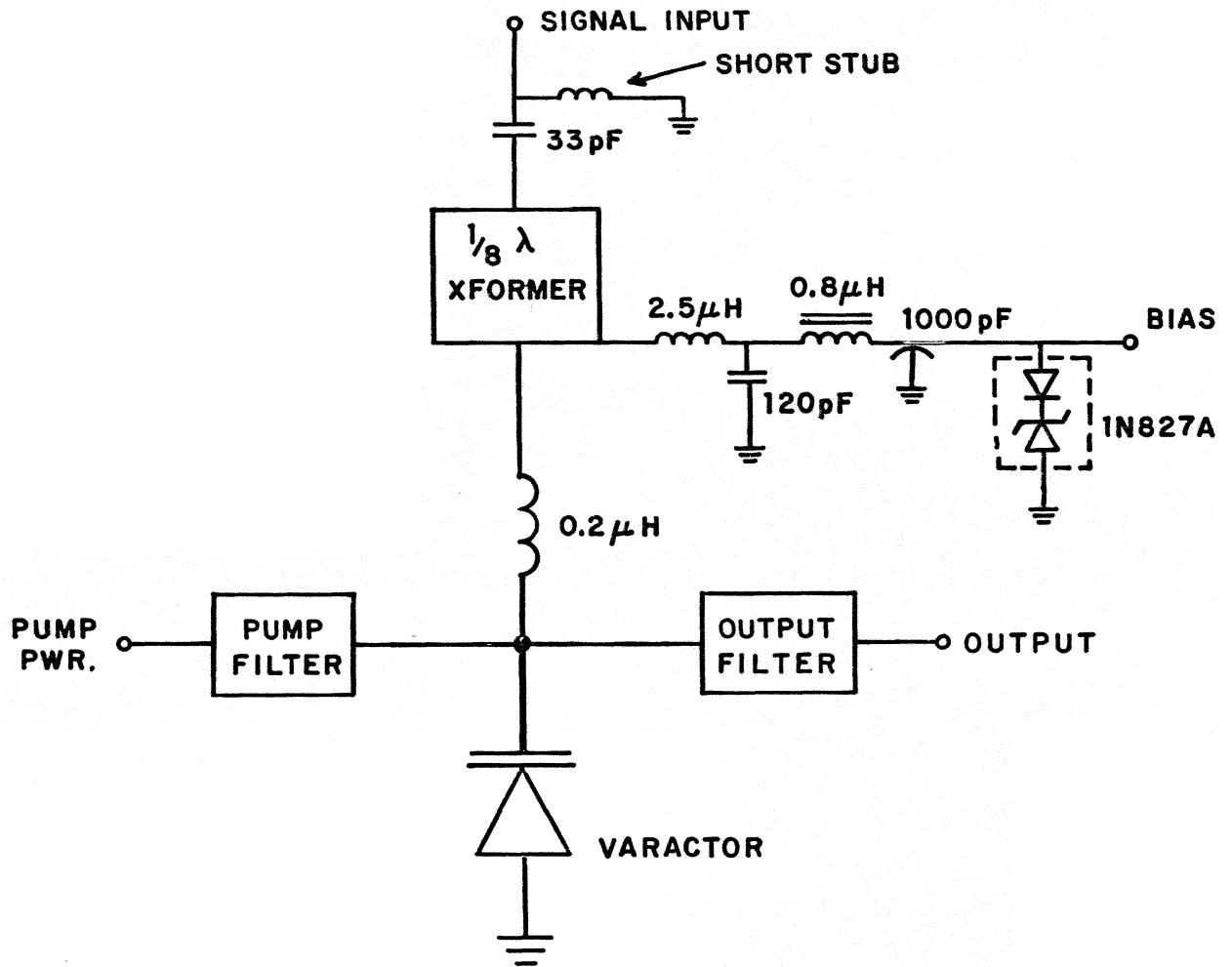


FIG. 4

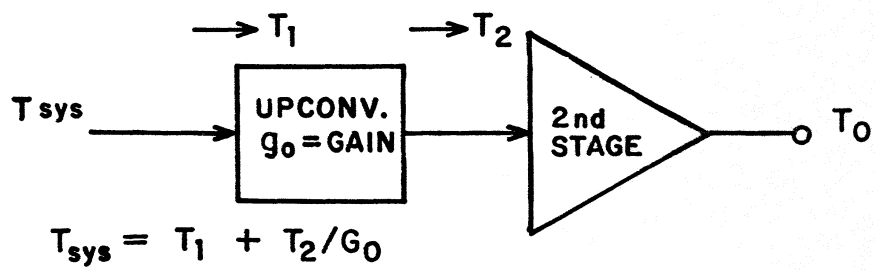


FIG. 5

Since the pump frequencies, output frequencies, and the difference frequencies of the signal and pump frequencies are in the GHz range, and the inductive reactance in the signal circuit is very high, we can neglect the possibility of an unwanted signal propagating in the signal line.

Using the given equations in Blackwell and Kotzbue, I made some analyses of the upconverters on the computer, as shown in Tables 2 and 3. One set of the computer printout is for room temperature operation and another set for 20°K operation. Of course, these analysis only assumes losses in the varactor diode but no loss in the matching and filtering networks. In our analysis there are two outputs, one set is for maximum gain of the upconverter and another set for minimum noise contribution by the upconverters. In all cases, we find it is more advantageous to build the upconverters for maximum gain and not for minimum noise because we know that an amplifier following the upconverter will have some noise contribution, and this contribution equation is as shown in Figure 5.

In any case, the system temperature would be the lowest if we can minimize the second stage noise contribution to the system, because the second stage noise contribution is high in our case. Let us take, for example, the 350 MHz upconverter. For the maximum gain case, we have noise contributed by the upconverter of about 1°K, gain of 10.8 dB (which is a ratio of approximately 12) and, assuming a second stage contribution of 20°K, the $T_{\text{sys}} = 1 + 20/12 = 2.7^\circ\text{K}$. Whereas, if we assume the same noise in the upconverter, we will have 0.5°K upconverter contribution and gain of 5.2 dB (which is a gain ratio of 3.3). This assumes the same 20°K second stage contribution $T_{\text{sys}} = 0.5 + 20/3.3 = 6.54^\circ\text{K}$. Therefore, the maximum gain case could be more advantageous.

The pump filter is very sharp and is a narrow-band, coupled-microstrip, double-pole filter. The loss through it is relatively high, approximately 2 dB. The output filter is a single-pole and relatively broad-band with approximately 0.75 dB loss. The output filter on the upconverter circuit board is really not sufficient to reject the pump frequency at the upconverter output, so we went to a commercial multipole filter at the output to give us pump attenuation. Both of these on-board filters were built with matching the output of 50Ω to the lower impedance of the diode in mind. The diode-driving impedances for the various upconverters are on the computer printouts listed.

The circuit board is made of Epsilam-10 material which is a polystyrene resin loaded with some very high dielectric powder, such as rutile, to make it into a substrate with dielectric constant of 10.3, clad with 2 ounces of copper on both sides. After the circuit board is made, it is mounted on an aluminum slab and into an aluminum case. The aluminum slab where the substrate is mounted has a mounting hole for the varactor which is gold plated to avoid corrosion caused by dissimilar metals. After the diode is mounted, it is soldered onto the substrate with low temperature silver solder. All solder joints on the substrate is soldered with low temperature silver solder. Biasing the varactor diode is done with a 0.008 diameter phosphor bronze coil of wire solder directly to the low impedance point on the signal transformer, approximately at the same point where the inductance is soldered for signal resonance with the varactor diode. This inductor is also the .008 dia. phosphor bronze wire with enamel coating. The biasing coil is connected to a low-pass filter. All three ports of the upconverter is accessed through SMA connectors mounted on an aluminum case. The bias lead is brought out through a feedthru capacitor.

The performance of the upconverters were measured with a mixer measurement set up. At room temperature we measured about 40°K with 7 dB gain from the prototype upconverters built in the 300-400 MHz range. Subsequently, we have built two more of these upconverters that went into the traveling feed receiver which is cryogenically cooled. The gains of these upconverters are a little over 9 dB and the noise contribution is on the order of 4°K to 5°K . Currently these upconverters are on the telescope operating with a system temperature of about 20°K at the input flange. See Figures 6 and 7 for gain and noise plot of the upconverters. See Figures 8 and 9 for receiver noise performance.

Conclusion

Upconverters are built for the traveling feed receiver at 300-400 MHz, 500-700 MHz, and 700-1000 MHz. The higher frequency upconverters have a little less gain as shown in the computer analysis. Therefore, the system temperature is higher but the application of the upconverters for radio astronomy is still the most desirable device in comparison to other existing amplifiers in regard to bandwidth and noise performance.

We have encountered some mechanical problems where the substrate coefficient of thermal expansion is much greater than the mounting case, but this was remedied by screwing down the substrate with additional screws. The mechanical rigidity of the coils was very poor with copper wires when they are cooled to cryogenic temperatures. We went to 0.008 diameter phosphor bronze wires to remedy the problem. There were very large sheer stresses on the varactor diode package that caused many varactor failures, but all we did was to enlarge the mounting holes through the substrate to allow for movements of the substrate with respect to the mounting slab. See Figure 10.

Conclusion (continued):

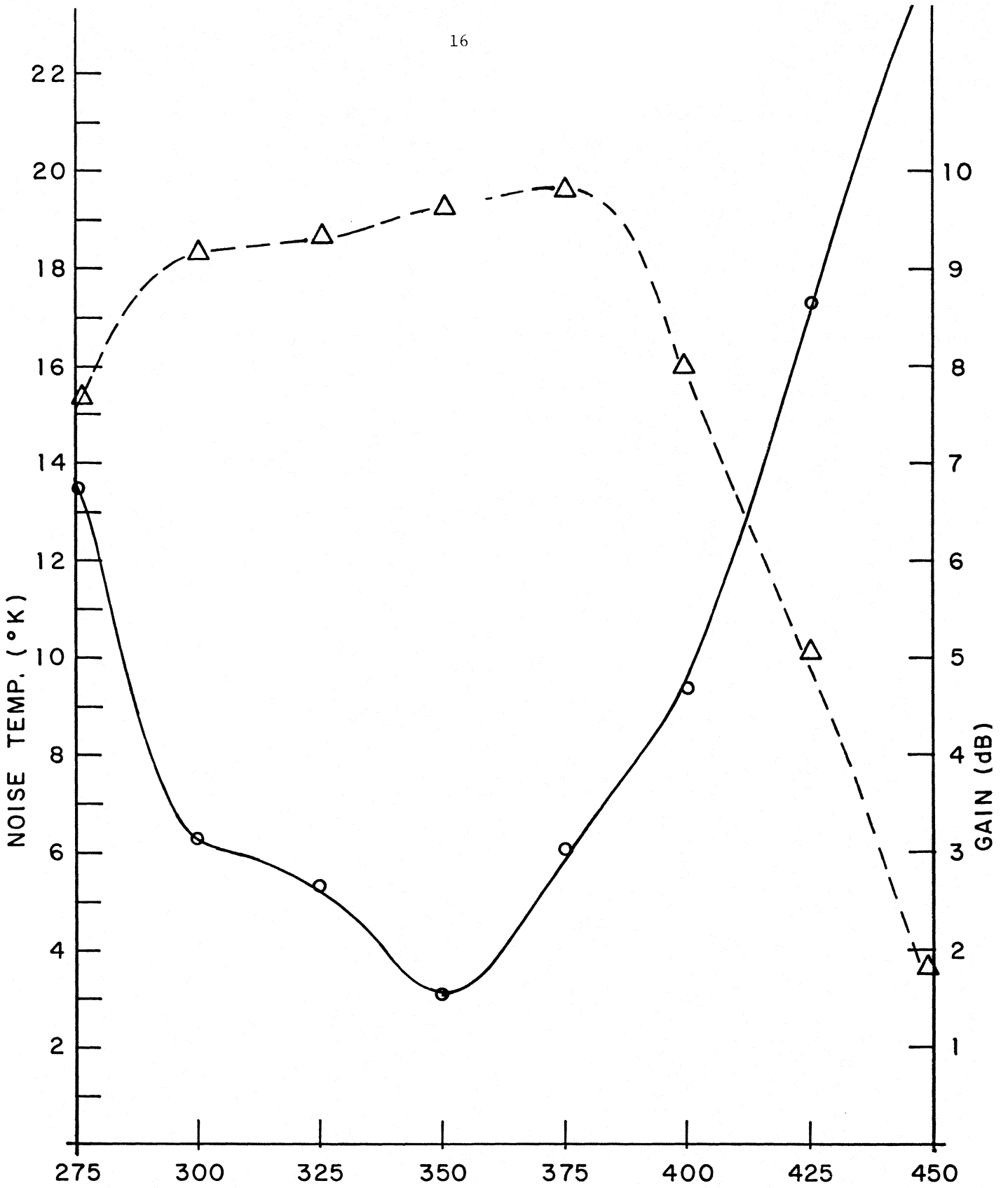
The last batch of upconverters had been in cool-down cycles for more than a dozen times and seem to be doing very well under such conditions. One of the 500-700 MHz upconverters seems to have lost a great deal of gain, as shown in Figure 9 where the noise performance is very poor. This is an earlier mechanical model which will be modified for greater mechanical stability.

Specifications/Vendors

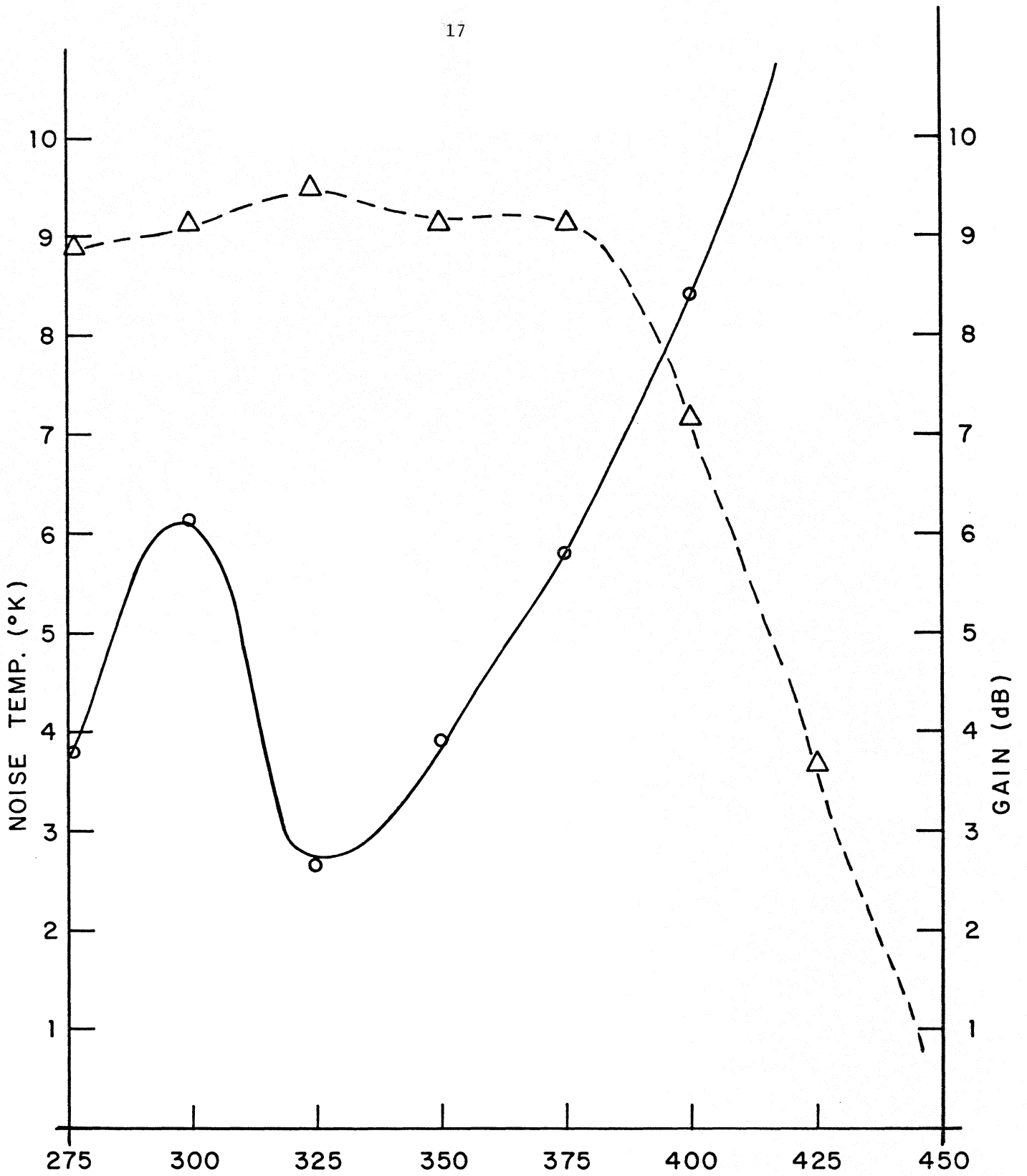
On the following pages are specification sheets for all of the materials that go into the upconverters and also a list of vendors for these materials.

Bibliography

- [1] J. M. Manley and H. E. Rowe, "Some General Properties of Nonlinear Elements, Part I: General Energy Relationships", IRE Proc., July 1956, pp. 904-913.
- [2] J. M. Manley and H. E. Rowe, "Some General Properties of Nonlinear Elements, Part II: Small Signal Theory", IRE Proc., May 1958, pp. 850-860.
- [3] Getsinger and Matthaei, "Some Aspects of the Design of Wide-Band Up-Converters and Nondegenerate Parametric Amplifiers", IEEE MTT, January 1964, pp. 77-87.
- [4] G. L. Matthaei, "Design Theory of Upconverters for Use as Vectorially-Tunable Filters", IEEE MTT, September 1961, pp. 425-435.
- [5] G. L. Matthaei, "A Study of the Optimum Design of Wide-Band Parametric Amplifiers and Up-Converters", IEEE MTT, January 1961, pp. 23-38.
- [6] P. Bura, "MIC Ku-Band Up-Converters", IEEE MTT, March 1973, pp. 136-137.
- [7] L. A. Blackwell and K. L. Kotzebue, Semiconductor Diode Parametric Amplifiers, Prentice-Hall: Englewood Cliffs, NJ, 1961.



UPCONVERTER GAIN & NOISE TEMPERATURE VS FREQUENCY
FIG. 6



UPCONVERTER No.1 NOISE TEMPERATURE VS FREQUENCY
FIG. 7

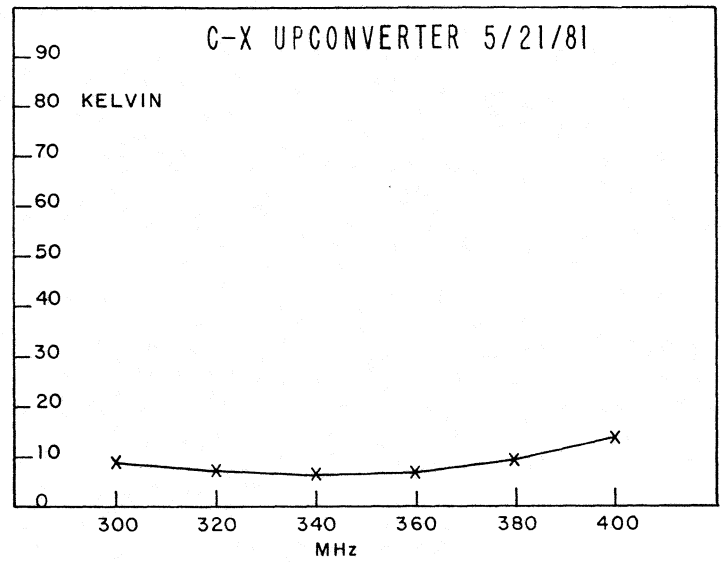
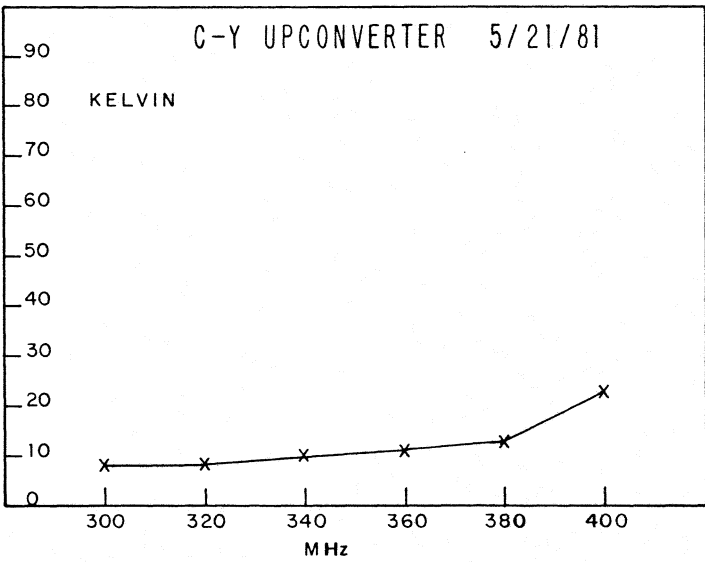
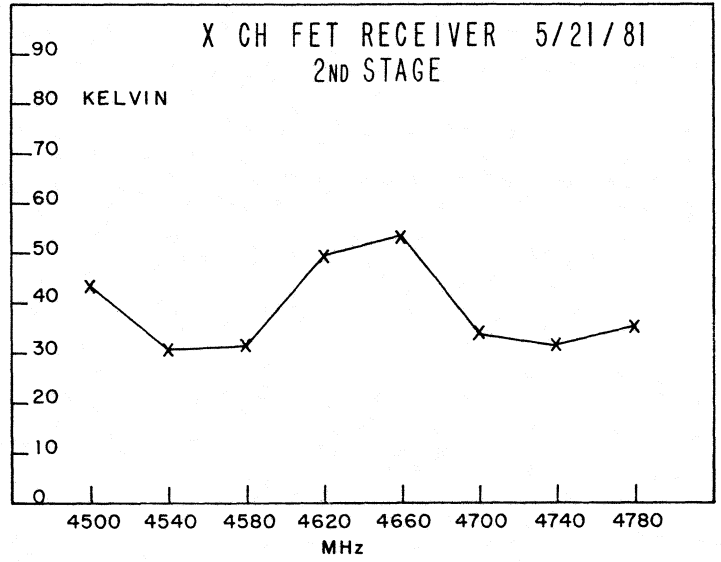
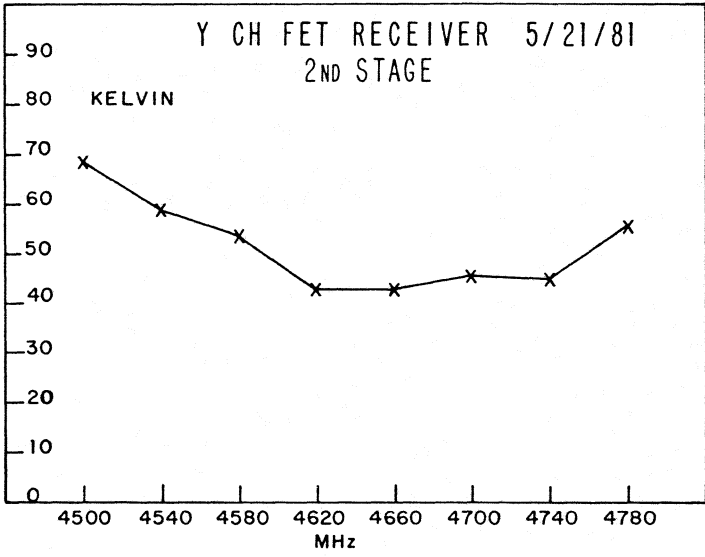


FIG. 8

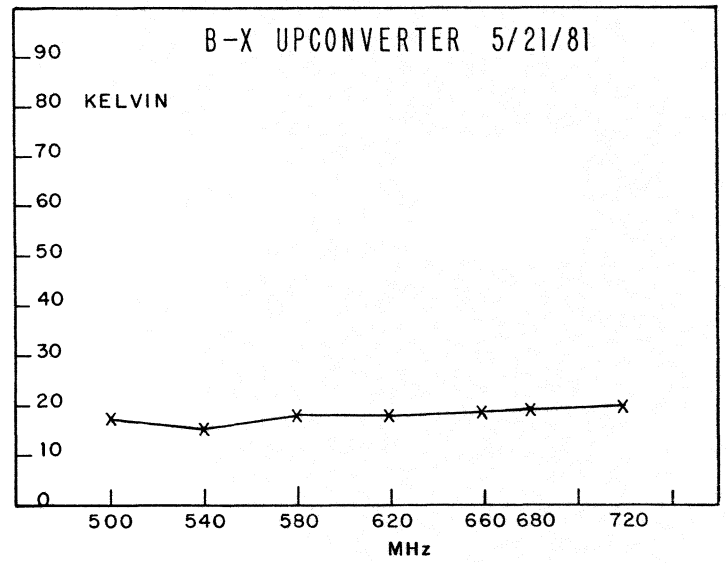
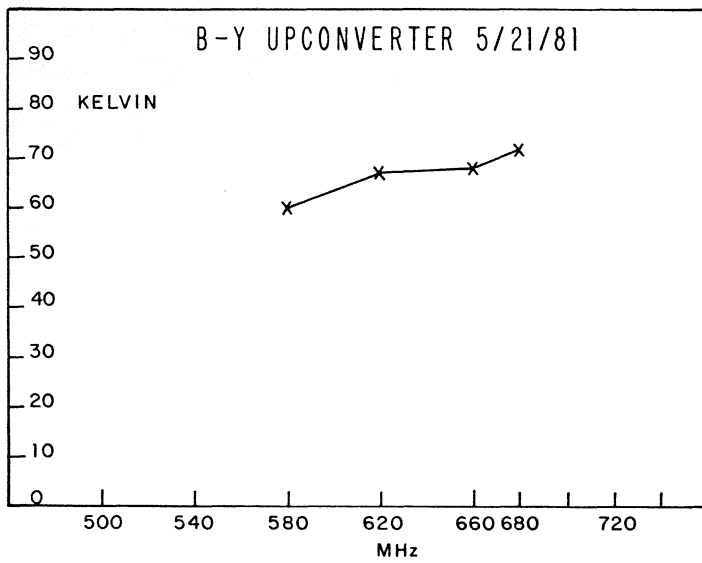
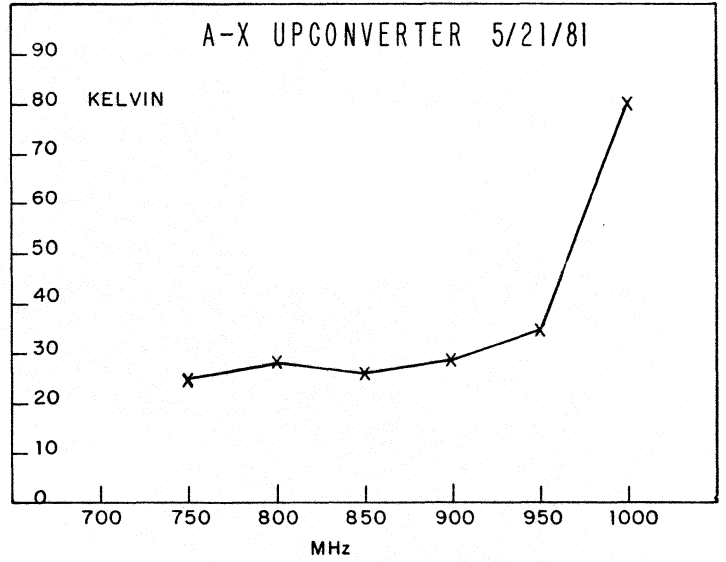
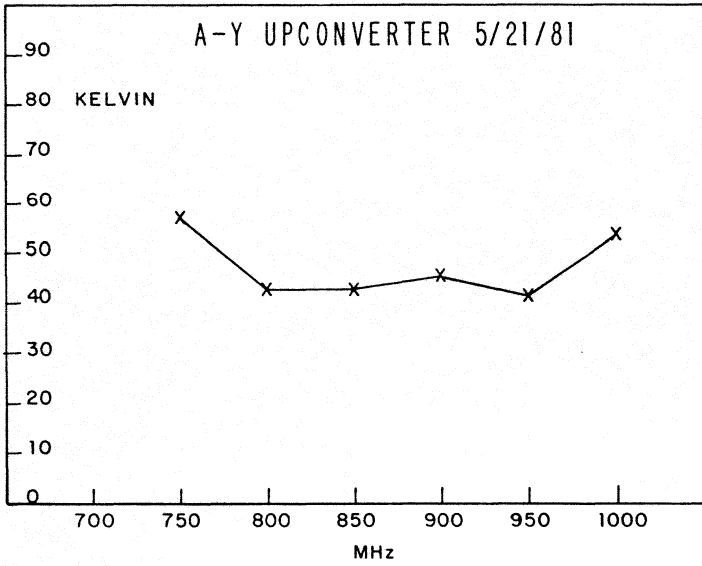


FIG. 9

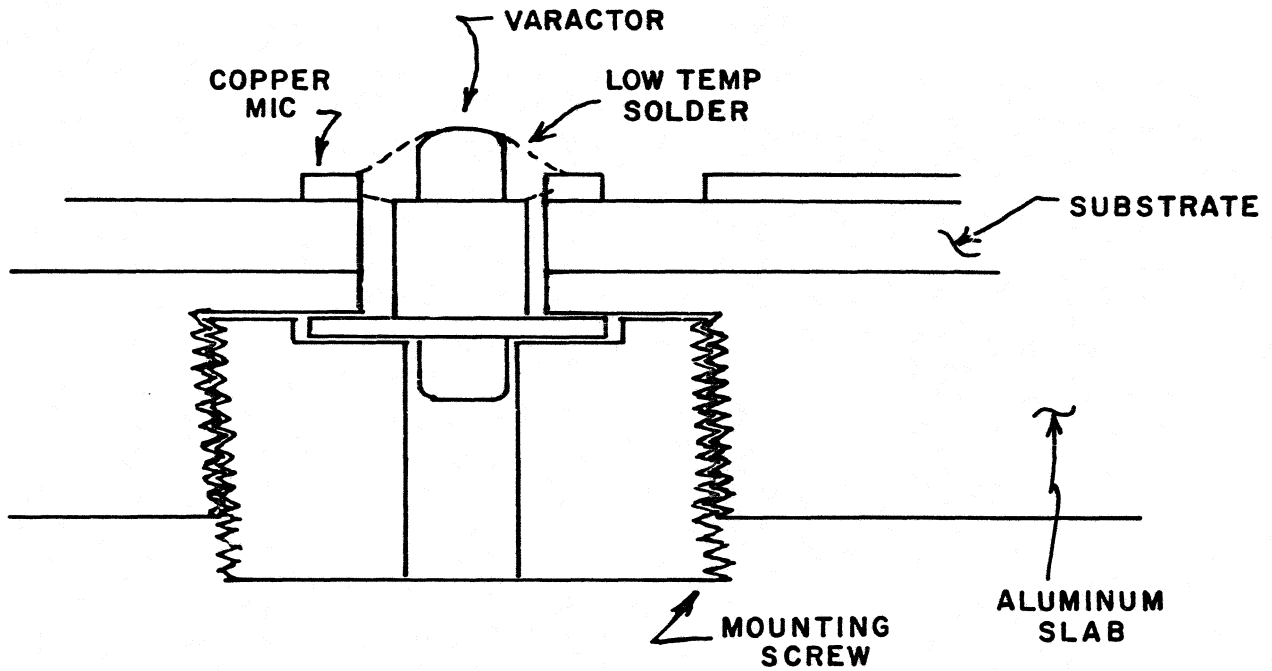


FIG. 10

Acknowledgement

Thanks to Jim Coe and Marion Pospieszalski for their suggestions and encouragement. Also, thanks to Ron Monk and Brown Cassell for graphic support, Tony Miano for drafting and Carolyn Dunkle for typing.

Specifications

| Manufacturer | Materials |
|-------------------------------|--|
| Sigmund Cohn Corporation | 0.008 diameter phosphor bronze wire, cold drawn with enamel. |
| Omni Spectra | Part No. 2502-0000-00, Model No. 251 |
| 3M | Epsilam-10 microwave substrate, 2 oz. copper clad both sides, 9" x 9" x 0.050" T'k |
| Dielectric Labs, Inc. | M17AH121JPS Chip capacitors, 120 pF M11AH330JPS Chip capacitors, 33 pF |
| Alpha Industries | GaAs varactor diodes #DVE 4556-71 $V_b = 6$ V min, $C_{j\delta} = 0.9-1.0$ pF, $f_{C6} = 250$ GHz, 4°K screened. |
| Indium Corporation of America | Indalloy #104 silver bearing solder. |

List of Vendors

Alpha Industries
20 Sylvan Road
Woburn, MA 01801
617-935-5150

Omni Spectra
140 Fourth Avenue
Waltham, MA 02254
617-890-4750

Dielectric Labs, Inc.
69 Albany Street
Cazenovia, NY 13035
315-655-8710

Sigmund Cohn Corporation
121 S. Columbus Avenue
Mt. Vernon, NY 10553
914-664-5300

Indium Corp. of America
P. O. Box 269
Utica, NY 13503
315-797-1630

3M
3M Center
St. Paul, MN 55101
612-733-1110

INDIUM CORPORATION OF AMERICA

Guide to Research Solder Kits

This chart identifies the Indalloy® solders in each Research Kit, and indicates the basic design characteristics of each solder. In all cases, Kit alloys come in wire form (approx. 4' of .047 diameter). But all are available in preforms, ribbon, foils, ingots, shot, rods, pellets, powders and spheres, as well. All high indium alloys are highly resistant to corrosion in alkaline media.

Kit #1—Indalloy Research Solder Kit
 Kit #2—Microelectronics Research Solder Kit
 Kit #3—Special Joining Research Solder Kit
 Kit #4—General Purpose Research Solder Kit
 Kit #5—Non-metallic Bonding Kit

| Indalloy® No. | Composition | Liquidus °C/°F | Solidus °C/°F | Plastic Range | Density lbs./cu.in. | Electrical Conductivity % of Copper | Thermal Conductivity Watts/CM C at 85 C | Thermal Coeff. of Expansion Micro In/ C at 20 C | Tensile Strength P.S.I. | Bond Holding Strength | Kit No. | | | | |
|---------------|--------------------------|-----------------|---------------|---------------|---------------------|-------------------------------------|---|---|-------------------------|-----------------------|---------|---|---|---|---|
| | | | | | | | | | | | 1 | 2 | 3 | 4 | 5 |
| 136 | 49Bi 21In 18Pb 12Sn | 58/136 | 58/136 | Eutectic | 0.3252 | 2.43 | | 12.8 | 6300 | | | | | | |
| 8 | 44In 42Sn 14Cd | 93/200 | 93/200 | Eutectic | 0.2693 | | 0.36 | 24 | | | | | | | |
| 1E | 52In 48Sn | 118/244 | 118/244 | Eutectic | 0.2635 | 11.7 | 0.34 | 20 | 1720 | 1630 | | | | | |
| 1 | 50In 50Sn | 125/257 | 118/244 | 7°C/13°F | 0.2635 | 11.7 | 0.34 | 20 | 1720 | 1630 | | | | | |
| 13 | 70In 15Sn 9.6Pb 5.4Cd | 125/257 (MP) | | | 0.2754 | | 0.39 | 27 | | 2000 | | | | | |
| 290 | 97In 3Ag | 143/290 | 143/290 | Eutectic | 0.2664 | 23.0 | 0.73 | 22 | 800 | | | | | | |
| 181 | 51.2Sn 30.6Pb 18.2Cd | 145/293 | 145/293 | Eutectic | 0.3050 | | 0.35 | 24.4 | | | | | | | |
| 2 | 80In 15Pb 5Ag | 149/300 | 142/290 | 7°C/10°F | 0.2834 | 13.0 | 0.43 | 10 | 2550 | 2150 | | | | | |
| 4 | 100In | 157/313 | 157/313 | Eutectic | 0.2640 | 24.0 | 0.78 | 29 | 575 | 890 | | | | | |
| 9 | 70Sn 18Pb 12In | 162/324 (MP) | | | 0.2812 | 12.2 | 0.45 | 24 | 5320 | 4190 | | | | | |
| 204 | 70In 30Pb | 174/345 | 160/320 | 14°C/26°F | 0.2956 | 8.8 | 0.38 | 28 | 3450 | | | | | | |
| 104 | 62.5Sn 36.1Pb 1.4Ag | 179/354 | 179/354 | Eutectic | 0.3036 | 11.6 | 0.31 | 25.2 | 7000 | | | | | | |
| 5 | 37.5Sn 37.5Pb 25In | 181/358 | 134/274 | 47°C/84°F | 0.3040 | 7.8 | 0.23 | 23 | 5260 | 4300 | | | | | |
| 106 | 63Sn 37Pb | 183/361 | 183/361 | Eutectic | 0.3032 | 11.5 | | 25 | 7700 | | | | | | |
| 205 | 60In 40Pb | 185/365 | 174/345 | 15°C/20°F | 0.3077 | 7.0 | 0.29 | 27 | 4150 | | | | | | |
| 7 | 50In 50Pb | 209/408 | 180/356 | 29°C/52°F | 0.3198 | 6.0 | 0.22 | 27 | 4670 | 2680 | | | | | |
| 121 | 96.5Sn 3.5Ag | 221/430 | 221/430 | Eutectic | 0.2657 | 16.0 | 0.33 | 30.2 | 2860 | | | | | | |
| 206 | 60Pb 40In | 225/437 | 195/383 | 30°C/54°F | 0.3355 | 5.2 | 0.19 | 26 | 5000 | | | | | | |
| 3 | 90In 10Ag | 237/459 | 141/285 | 96°C/174°F | 0.2722 | 22.1 | 0.67 | 15 | 1650 | 1600 | | | | | |
| 133 | 95Sn 5Sb | 240/464 | 232/450 | 8°C/14°F | 0.2617 | 11.9 | 0.28 | 31.1 | 5900 | | | | | | |
| 10 | 75Pb 25In | 264/508 | 250/482 | 14°C/26°F | 0.3599 | 4.6 | 0.18 | 26 | 5450 | 3520 | | | | | |
| 150 | 81Pb 19In | 280/536 | 270/518 | 10°C/18°F | 0.3707 | 4.5 | 0.17 | 27 | 5550 | | | | | | |
| 6 | 92.86Pb 4.76In 2.38Ag | 300/572 (MP) | | | 0.3982 | 5.5 | 0.25 | 25 | 4560 | 2830 | | | | | |
| 164 | 92.5Pb 5In 2.5Ag | 300/572 (MP) | | | 0.3978 | 5.5 | 0.25 | 25 | 4560 | 2830 | | | | | |
| 165 | 97.5Pb 1.5Ag 1Sn | 309/588 | 309/588 | Eutectic | 0.4072 | 6.0 | 0.23 | 30.4 | 4420 | | | | | | |
| 12 | 90Pb 5In 5Ag | 310/590 | 290/554 | 20°C/36°F | 0.3971 | 5.6 | 0.25 | 27 | 5730 | 3180 | | | | | |
| 171 | 95Pb 5Sn | 314/597 | 311/592 | 3°C/5°F | 0.3980 | 8.8 | 0.23 | 29.8 | 3400 | | | | | | |
| 11 | 95Pb 5In | 314/598 | 293/558 | 21°C/40°F | 0.3980 | 5.1 | 0.21 | 29 | 4330 | 3220 | | | | | |

MP - Melting Point

OMNI SPECTRA



**MINIATURE COAXIAL CONNECTOR
PANEL AND BULKHEAD MOUNT**

OSM Panel and Bulkhead Mount Connectors are designed to meet requirements for coaxial transitions to components, cavities, waveguides and strip transmission lines.

Certain types make use of a captured center contact, while others are supplied with a separate, removable center contact to facilitate assembly. Some types may be supplied with a choice of center contact on special order; with or without capturing.

PANEL AND BULKHEAD MOUNT • SOLDER POT TERMINAL

| | | | |
|--|--------------|-----------------|--|
| CAPTURED CENTER CONTACT SOLDER POT TERMINAL | | | |
| PART NUMBER | 2052-0000-00 | | |
| MODEL NUMBER | 215 | See footnote #1 | |
| CAPTURED CENTER CONTACT SOLDER POT TERMINAL | | | |
| PART NUMBER | 2051-0000-00 | | |
| MODEL NUMBER | 214-7871 | See footnote #1 | |
| CAPTURED CENTER CONTACT SOLDER POT TERMINAL | | | |
| PART NUMBER | 2052-1350-00 | | |
| MODEL NUMBER | — | See footnote #1 | |
| CAPTURED CENTER CONTACT SOLDER POT TERMINAL | | | |
| PART NUMBER | 2051-1350-00 | | |
| MODEL NUMBER | — | See footnote #1 | |

1. For passivated stainless steel finish versions, change the suffix "00" to "02" in the part number or add suffix "SF" to the model number.

SIGMUND COHN CORPORATION

Bronze Wire

PURE BASE METALS

| | REF. | PURITY % or COMPOSITION | RESISTIVITY (Ω /cm @ 0°C) | | TEMP. COEFF. OF RESISTANCE (0-100°C) | | TENSILE STRENGTH (PSI x 1000) | | ELON- GATION (Percent) | | MELTING POINT (Solidus) °C | DENSITY (g/cm ³) | FORMS AVAILABLE | | |
|--------------------|------|-------------------------------|--------------------------------------|--------|--|--------|-------------------------------------|--------|------------------------------|--------|-------------------------------------|---------------------------------|--------------------|---|---|
| | | | Hard | Annid. | Hard | Annid. | Hard | Annid. | Hard | Annid. | | | S | W | R |
| Iron | | 99.9+% | 61 | 54 | .0062 | .0065 | 180 | 34 | 2 | 40 | 1536 | 7.9 | - | ✓ | ✓ |
| 205 Nickel | | 99% | 60 | 54 | .0044 | .0048 | 130 | 60 | 2 | 36 | 1440 | 8.9 | - | ✓ | ✓ |
| 270 Nickel | | 99.97% | 40 | 38 | .0064 | .0067 | 95 | 48 | 2 | 36 | 1452 | 8.9 | - | ✓ | ✓ |
| RT Nickel CP Ni | (E) | 99.98% | 39.4 | 37 | .0064 | .00676 | 100 | 48 | 2 | 36 | 1452 | 8.9 | - | ✓ | ✓ |
| Tungsten | (F) | 99.98+% | 39 | 33 | .0036 | .0048 | 320 | 160 | 1.5 | 16 | 3410 | 19.3 | - | ✓ | - |
| Copper | | 99.98% | 9.44 | 9.24 | .0041 | .0043 | 76 | 32 | 1.5 | 46 | 1083 | 8.93 | - | ✓ | ✓ |

COPPER BASE ALLOYS

| | REF. | PURITY % or COMPOSITION | RESISTIVITY (Ω /cm @ 0°C) | | TEMP. COEFF. OF RESISTANCE (0-100°C) | | TENSILE STRENGTH (PSI x 1000) | | ELON- GATION (Percent) | | MELTING POINT (Solidus) °C | DENSITY (g/cm ³) | FORMS AVAILABLE | | |
|----------------------------|------|-------------------------------|--------------------------------------|--------|--|--------|-------------------------------------|--------|------------------------------|--------|-------------------------------------|---------------------------------|--------------------|---|---|
| | | | Hard | Annid. | Hard | Annid. | Hard | Annid. | Hard | Annid. | | | S | W | R |
| Copper-Silver | | Ag-15% Cu | 13.8 | 12.2 | .0028 | .0031 | 96 | 64 | 2 | 18 | 780 | 10.2 | - | ✓ | ✓ |
| Phosphor Bronze Grade A | | Cu 95%-Sn 5% | 66 | 65 | .00072 | .00074 | 130 | 60 | 2 | 58 | 950 | 8.86 | - | ✓ | ✓ |
| Phosphor Bronze Grade C | | Cu 92%-Sn 8% | 89 | 84 | .00058 | .00063 | 150 | 70 | 2 | 60 | 880 | 8.8 | - | ✓ | ✓ |
| Beryllium Copper #10 | | Be 0.6%-Cu 96.9%-Co 2.5% | 44 | 16 | .001 | .0028 | 113 | 64 | 2 | 20 | 1050 | 8.75 | - | ✓ | ✓ |
| Beryllium Copper #25 | | Be 2%-Cu 97.75%-Co 0.25% | 71 | 38 | .00085 | .0015 | 210 | 100 | 2 | 28 | 870 | 8.23 | - | ✓ | ✓ |

3M

EPSILAM-10 MICROWAVE SUBSTRATE

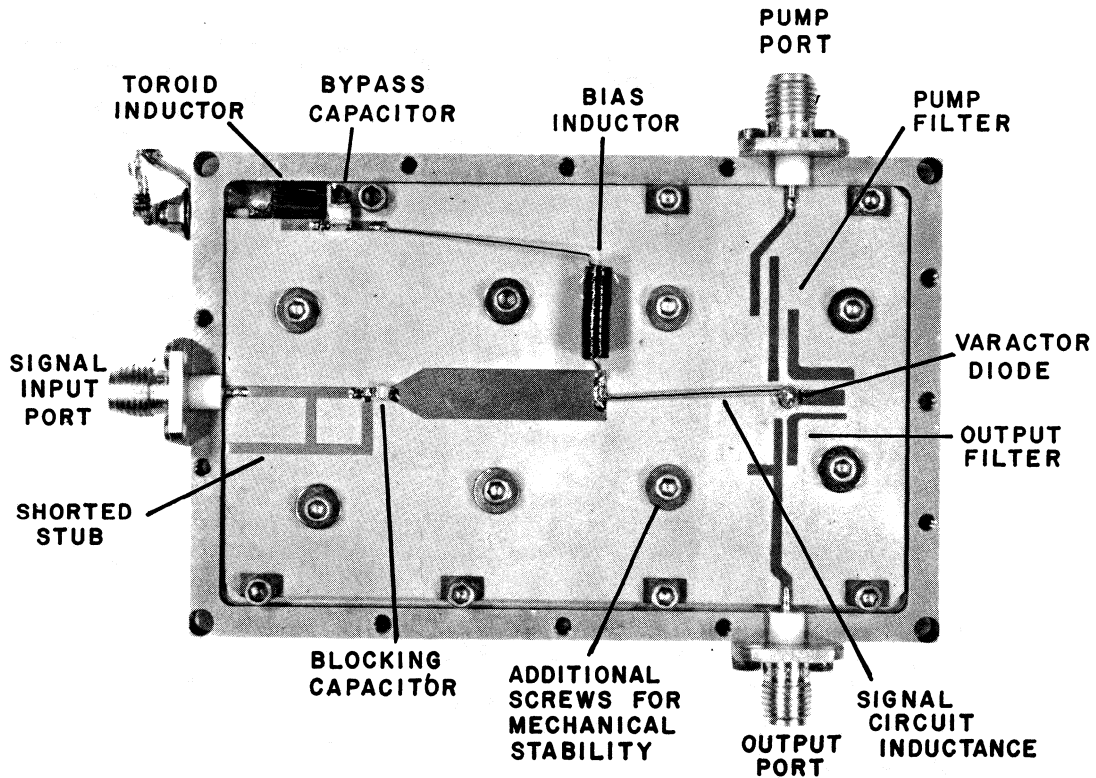
| EPSILAM-10 [®] TYPICAL PROPERTIES | | TEST METHODS |
|--|--|-----------------|
| *Effective Dielectric Constant (C Band Microstrip) | | |
| 25 mil | 10.2 ± .5 | |
| 50 mil | 10.6 ± .5 | 3M |
| *Z Direction Dielectric Constant ** (1 to 10 GHz) | 10.0 ± 0.2 | 3M |
| *Water Absorption (24 hr. H ₂ O) | 0.7 - 1.0% | MIL-P 13949E |
| *Copper Adhesion (lbs/in.) | 8 min. (ED Copper) | MIL-P 13949E |
| *Etching Shrinkage | | |
| With all copper and aluminum removed | 4 - 5 mil/in. | |
| With 1 oz. copper ground plane | 0.3 - 0.5 mil/in. | 3M |
| With aluminum ground plane | ± 0.0 | |
| *Dissipation Factor | .002 | 3M |
| Temperature Coefficient of ϵ_r (ppm/°C) | 570 (-50° C to +170° C) | |
| Coefficient of Thermal Expansion (ppm/°C) | 20 - 25 (est.) | D-696 |
| Tensile Strength (psi) | 1400 | D-229 |
| Specific Gravity | 2.98 gm/Cm ³ | D-792 |
| Thermal Conductivity (cal/sec. - cm°C) | 8.9 x 10 ⁻⁴ | D-696 |
| Elongation at Break | > 6% | -- |
| Tensile Modulus (psi) | 35,000 | -- |
| NASA Outgassing and Condensables | 0.04% and 0.00% | -- |
| Shore Hardness | D-65 | -- |
| Bonding Process | Direct—no interlayer | -- |
| Processing | Standard printed circuit methods | -- |
| Solderability | At least 520° F—stands red hot hand soldering | -- |
| Fabrication | Can be machined, drilled, sheared and punched—the limitation on bonding and forming is the elongation of the copper. | -- |
| Substrate Color | Gray | -- |
| Substrate Thickness | .010", .025", .050", .075" and .100" | -- |
| Sheet Size | 9" x 9" | -- |
| Attenuation per db/wavelength (λ) (50 ohm microstripline on 25 mil E-10) | = db/ λ from 1-6 GHz .18 | -- |
| Unloaded Q | 145 | -- |

E-10^{*} Typical properties continued on backTest data for aluminum clad Epsilam-10^{*} is based on the .063" aluminum thickness.*Specification Values
Product is supplied in accordance with these values.

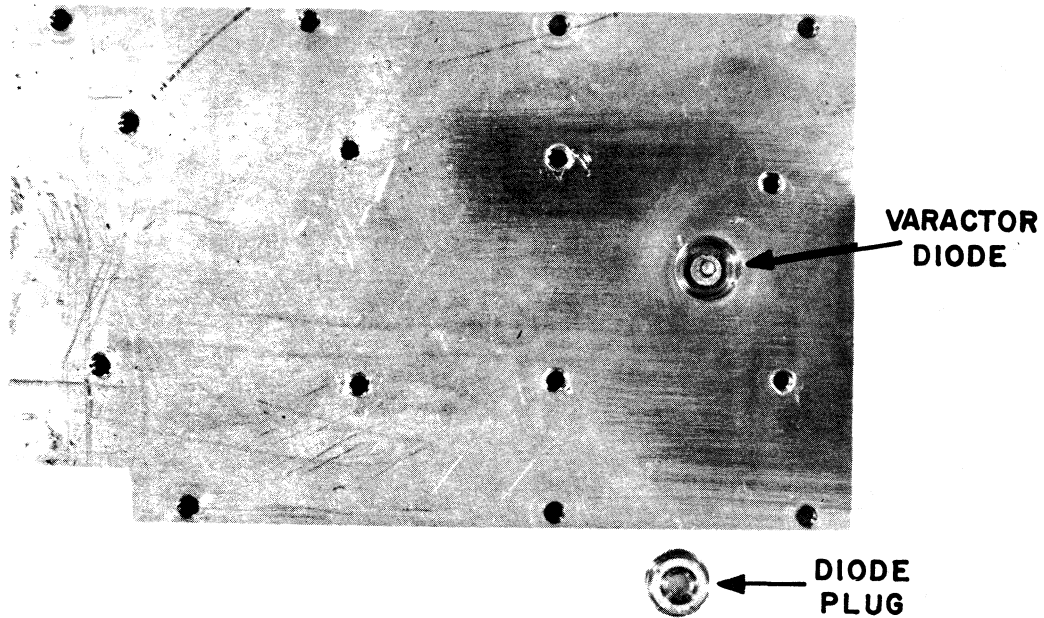
**Plated Disk Test

†Clamping pressure should be properly distributed to avoid indenting the E-10^{*}

| EPSILAM-10 [®] TYPICAL PROPERTIES | | TEST METHODS |
|---|--|--------------|
| Specific Heat | .2 cal/gm °C (determined from specific heats of ingredients) | -- |
| Change in ϵ_r with frequency (1-12 GHz) | negligible | -- |
| Change in Dielectric Constant with Temp. (-50° C to +170° C) | ≈ 1% | -- |
| 50 ohm line width on 50 mil ground plane 25 mil ground plane | 40 mils 20 mils | -- |



Shown here is the back side of the aluminum slab into which the varactor diode is screwed. The microstrip board would be mounted on the other side of this slab.



This is the complete assembly of a 500-700 MHz upconverter with the circuit board mounted on the aluminum slab and then in turn mounted in the up-converter case.